ELEMENT MATERIALS TECHNOLOGY
(formerly PCTEST)
7185 Oakland Mills Road, Columbia, MD 21046 USA
Tel. +1.410.290.6652 / Fax +1.410.290.6654
http://www.element.com

RF EXPOSURE PART 0 TEST REPORT

Applicant Name:
Samsung Electronics Co., Ltd.
129, Samsung-ro, Maetan dong,
Yeongtong-gu, Suwon-si
Gyeonggi-do, 16677, Korea

Date of Testing:
09/02/2024 - 10/30/2024
Test Site/Locations:
Element, Columbia, MD, USA
Element Morgan Hill, CA, USA
Element, Suwon, Korea
Document Serial No.:
1M2408260066-04.A3L

FCC ID:	**A3LSMS936B**
APPLICANT:	**SAMSUNG ELECTRONICS CO., LTD.**

Report Type:	Part 0 SAR Characterization
DUT Type:	Portable Handset
Model(s):	SM-S936B/DS
Additional Model(s):	SM-S936B

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them. Test results reported herein relate only to the item(s) tested.

RJ Ortanez
Executive Vice President

The SAR Tick is an initiative of the Mobile & Wireless Forum (MWF). While a product may be considered eligible, use of the SAR Tick logo requires an agreement with the MWF. Further details can be obtained by emailing: sartick@mwfai.info.

TABLE OF CONTENTS

1 DEVICE UNDER TEST

1.1 Device Overview

Band & Mode	Operating Modes	Tx Frequency
GSM/GPRS/EDGE 850	Voice/Data	824.20 - 848.80 MHz
GSM/GPRS/EDGE 1900	Voice/Data	1850.20 - 1909.80 MHz
UMTS 850	Voice/Data	826.40 - 846.60 MHz
UMTS 1750	Voice/Data	1712.4 - 1752.6 MHz
UMTS 1900	Voice/Data	1852.4 - 1907.6 MHz
LTE Band 12	Voice/Data	699.7 - 715.3 MHz
LTE Band 17	Voice/Data	706.5 - 713.5 MHz
LTE Band 13	Voice/Data	779.5 - 784.5 MHz
LTE Band 26	Voice/Data	814.7 - 848.3 MHz
LTE Band 5	Voice/Data	824.7 - 848.3 MHz
LTE Band 66	Voice/Data	1710.7 - 1779.3 MHz
LTE Band 4	Voice/Data	1710.7 - 1754.3 MHz
LTE Band 25	Voice/Data	1850.7 - 1914.3 MHz
LTE Band 2	Voice/Data	1850.7 - 1909.3 MHz
LTE Band 41	Voice/Data	2498.5 - 2687.5 MHz
NR Band n5	Voice/Data	826.5 - 846.5 MHz
NR Band n66	Voice/Data	1712.5 - 1777.5 MHz
NR Band n25	Voice/Data	1852.5 - 1912.5 MHz
NR Band n2	Voice/Data	1852.5 - 1907.5 MHz
NR Band n41	Voice/Data	2501.01 - 2685 MHz
NR Band n77	Voice/Data	3455.01 - 3544.98 MHz; 3705 - 3975 MHz
2.4 GHz WIFI	Voice/Data	2412 - 2472 MHz
5 GHz WIFI	Voice/Data	U-NII-1: 5180 - 5240 MHz U-NII-2A: 5260 - 5320 MHz U-NII-2C: 5500 - 5720 MHz U-NII-3: 5745 - 5825 MHz U-NII-4: 5845 - 5885 MHz
6 GHz WIFI	Voice/Data	U-NII-5: 5935 - 6415 MHz U-NII-6: 6435 - 6515 MHz U-NII-7: 6535 - 6875 MHz U-NII-8: 6895 - 7115 MHz
2.4 GHz Bluetooth	Data	2402 - 2480 MHz
NFC	Data	13.56 MHz
UWB	Data	6489.6 - 7987.2 MHz

1.2 Time-Averaging Algorithm for RF Exposure Compliance

The purpose of this report is to show SAR Characterization of WWAN sub-6/WLAN/BT (Part0) and to demonstrate that the EUT meets FCC SAR limits when transmitting in static transmission scenario at maximum allowable time-averaged power levels (Part1).

1.2.1 Nomenclature

Technology	Term	Description
WWAN Sub-6 /WLAN/BT	P_{limit}	Power level that corresponds to the exposure design target (*SAR_design_target)* after accounting for all device design related uncertainties
	P_{max}	Maximum tune up output power
	SAR_design_target	Target SAR level < FCC SAR limit after accounting for all device design related uncertainties
	SAR Char	Table containing *Plimit* for all technologies and bands

1.2.2 Time-Averaged Algorithm

This Device is enabled with the Qualcomm® Smart Transmit Gen2 feature with antenna grouping. This feature performs time-averaging algorithm in real time to control and manage transmitting power and ensure the time-averaged RF exposure is in compliance with FCC requirements all the time. Refer to Compliance Summary document for detailed description of Qualcomm® Smart Transmit feature (report SN could be found in Section 1.3– Bibliography).

Note that NTN operations are not enabled with Smart Transmit.

The Smart Transmit algorithm maintains the time-averaged transmit power, in turn, time-averaged RF exposure of *SAR_design_target* or *PD_design_target*, below the predefined time-averaged power limit (i.e., P_{limit} for WWAN sub-6/WLAN/BT radio, and *input.power.limit* for 5G mmW NR), for each characterized technology and band. Characterization is achieved by determining P_{limit} for WWAN sub-6/WLAN/BT that corresponds to the exposure design targets after accounting for all device design related uncertainties, i.e., SAR_design_target (<FCC SAR Limit) for sub-6 radio. The SAR characterization is denoted as SAR char in this report (see SAR Summary Section and Part 0 SAR Test Results for P_{limit} Calculations Appendix).

Smart Transmit allows the device to transmit at higher power instantaneously, as high as P_{max}, when needed, but enforces power limiting to maintain time-averaged transmit power to P_{limit}. Below table shows P_{limit} EFS settings and maximum tune up output power P_{max} configured for this EUT for various transmit conditions (Device State Index DSI). Note that the device uncertainty for WWAN sub-6/WLAN/BT is 1.0dB for this EUT.

The maximum time-averaged output power (dBm) for any WWAN sub-6/WLAN/BT technology, band, and DSI is the minimum of ("P_{limit} EFS" and "Maximum tune up output power P_{max}") + 1dB device uncertainty. SAR values in this report were scaled to this maximum time-averaged output power to determine compliance per KDB Publication 447498 D01v06.

1.3 Bibliography

Report Type	Report Serial Number
RF Exposure Part 1 Test Report	1M2408260066-01.A3L
RF Exposure Part 2 Test Report	1M2408260066-02.A3L

2 SAR AND POWER DENSITY MEASUREMENTS

The FCC and Innovation, Science, and Economic Development Canada have adopted the guidelines for evaluating the environmental effects of radio frequency (RF) radiation in ET Docket 93-62 on Aug. 6, 1996 and Health Canada Safety Code 6 to protect the public and workers from the potential hazards of RF emissions due to FCC-regulated portable devices.

The safety limits used for the environmental evaluation measurements are based on the criteria published by the American National Standards Institute (ANSI) for localized specific absorption rate (SAR) in IEEE/ANSI C95.1-1992 Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz. and Health Canada RF Exposure Guidelines Safety Code 6 **Error! Reference source not found.**. The measurement procedure described in IEEE/ANSI C95.3-2002 Recommended Practice for the Measurement of Potentially Hazardous Electromagnetic Fields - RF and Microwave **Error! Reference source not found.** is used for guidance in measuring the Specific Absorption Rate (SAR) due to the RF radiation exposure from the Equipment Under Test (EUT). These criteria for SAR evaluation are similar to those recommended by the International Committee for Non-Ionizing Radiation Protection (ICNIRP) in Biological Effects and Exposure Criteria for Radiofrequency Electromagnetic Fields," Report No. Vol 74. SAR is a measure of the rate of energy absorption due to exposure to an RF transmitting source. SAR values have been related to threshold levels for potential biological hazards.

2.1 SAR Definition

Specific Absorption Rate is defined as the time derivative (rate) of the incremental energy (dU) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dV) of a given density (ρ). It is also defined as the rate of RF energy absorption per unit mass at a point in an absorbing body (see Equation 2-1).

Equation 2-1
SAR Mathematical Equation

$$SAR = \frac{d}{dt}\left(\frac{dU}{dm}\right) = \frac{d}{dt}\left(\frac{dU}{\rho dv}\right)$$

SAR is expressed in units of Watts per Kilogram (W/kg).

$$SAR = \frac{\sigma \cdot E^2}{\rho}$$

where:

σ = conductivity of the tissue-simulating material (S/m)
ρ = mass density of the tissue-simulating material (kg/m^3)
E = Total RMS electric field strength (V/m)

NOTE: The primary factors that control rate of energy absorption were found to be the wavelength of the incident field in relation to the dimensions and geometry of the irradiated organism, the orientation of the organism in relation to the polarity of field vectors, the presence of reflecting surfaces, and whether conductive contact is made by the organism with a ground plane.[6]

3 PART 0 SAR CHARACTERIZATION

3.1 SAR Characterization

3.1.1 DSI and SAR Determination

This device uses different Device State Index (DSI) to configure different time averaged power levels based on certain exposure scenarios. Depending on the detection scheme implemented in the smartphone, the worst-case SAR was determined by measurements for the relevant exposure conditions for that DSI. Detailed descriptions of the detection mechanisms are included in the operational description.

When 1g SAR and 10g SAR exposure comparison is needed, the worst-case was determined from SAR normalized to 1g or 10g SAR limit.

The device state index (DSI) conditions used in Table 2-1 represent different exposure scenarios.

Table 3-1
DSI and Corresponding Exposure Scenarios

Scenario	Description	SAR Test Cases
Head (DSI = 1)	▪ Device positioned next to head ▪ Receiver Active	*Head SAR per KDB Publication 648474 D04*
Hotspot mode (DSI = 0)	▪ Device transmits in hotspot mode near body ▪ Hotspot Mode Active	*Hotspot SAR per KDB Publication 941225 D06*
Phablet (DSI = 0)	▪ Device is held with hand	*Phablet SAR per KDB Publication 648474 D04 & KDB Publication 616217 D04*
Body-worn (DSI = 0)	▪ Device being used with a body-worn accessory	*Body-worn SAR per KDB Publication 648474 D04*

3.1.2 SAR_Design_Target

SAR_design_target is determined by ensuring that it is less than FCC SAR limit after accounting for total device designed related uncertainties specified by the manufacturer (see Table 2-2).

Table 3-2
***SAR_design_target* Calculations**

SAR_design_target			
$SAR\_design\_target < SAR\_regulatory\_limit \times 10^{\frac{-Total\ Uncertainty}{10}}$			
1g SAR (W/kg)		**10g SAR (W/kg)**	
Total Uncertainty	1.0 dB	*Total Uncertainty*	1.0 dB
SAR_regulatory_limit	1.6 W/kg	*SAR_regulatory_limit*	4.0 W/kg
SAR_design_target	1.0 W/kg	*SAR_design_target*	2.5 W/kg

3.1.3 SAR Char

SAR test results corresponding to *Pmax/Plimit* for each antenna/technology/band/DSI can be found in SAR Summary Section and Part 0 SAR Test Results for Plimit Calculations Appendix.

Plimit is calculated by linearly scaling with the measured SAR at the Ppart0 to correspond to the *SAR_design_target*. When *Plimit* < *Pmax*, *Ppart0* was used as Plimit in the Smart Transmit EFS. When *Plimit* > *Pmax* and *Ppart0*=Pmax, calculated *Plimit* was used in the Smart Transmit EFS. For some bands/modes, the manufacture selected a lower *Plimit*. All reported SAR obtained from the Ppart0 SAR tests was less than *SAR_Design_target*+ 1 dB Uncertainty. The final *Plimit* determination for each exposure scenario corresponding to *SAR_design_target* are shown in Table 2-3.

Table 3-3
***PLimit* Determination**

Device State Index (DSI)	*PLimit* Determination Scenarios
0	The worst-case SAR exposure is determined as maximum SAR normalized to the limit (i.e. lowest P_{limit}) among: 1. Body Worn SAR 2. Extremity SAR measured at 0 mm for all surfaces. 3. Hotspot SAR at 10 mm
1	P_{limit} is calculated based on 1g Head SAR

Notes:

- When $P_{max} < P_{limit}$ EFS, the DUT will operate at a power level up to P_{max}

- All P_{limit} EFS and maximum tune up output power P_{max} levels entered in above Table correspond to average power levels after accounting for duty cycle in the case of TDD, GMSK, or OFDM modulation schemes (e.g. GSM, LTE TDD and WLAN/BT).

- Maximum tune up output power P_{max} is used to configure EUT during RF tune up procedure. The maximum allowed output power is equal to maximum Tune up output power + 1dB device design uncertainty.

- All MIMO P_{max} and P_{limit} are defined per antenna chain.

Measurement Condition: All conducted power and SAR measurements in this report (Part 1 test) were performed by setting Reserve_power_margin (Smart Transmit EFS entry) to 0dB.

Table 3-4
SAR Characterizations

Exposure Scenario			Maximum Tune-Up Output Power*	Body-Worn, Hotspot, or Phablet	Head
Averaging Volume				1g/10g	1g
Spacing				10mm, 0mm	0mm
Configuration					
DSI				0	1
Technology/Band	Antenna	Antenna Group	P_{max}	P_{limit}	P_{limit}
GSM 850	A	AG0	24.1	27.4	32.2
GSM 850	E	AG1	24.1	27.6	20.5
GSM 1900	A	AG0	21.6	20.0	32.0
UMTS 850	A	AG0	24.5	28.0	32.5
UMTS 850	E	AG1	24.5	26.6	21.0
UMTS 1750	A	AG0	23.5	20.0	30.5
UMTS 1900	A	AG0	23.5	19.0	30.9
LTE Band 12/17	A	AG0	24.0	27.4	32.7
LTE Band 12/17	E	AG1	24.0	26.5	21.0
LTE Band 13	A	AG0	24.0	28.4	32.1
LTE Band 13	E	AG1	24.0	25.9	21.0
LTE Band 26/5	A	AG0	24.0	26.2	32.2
LTE Band 26/5	E	AG1	24.0	25.8	21.0
LTE Band 66/4	A	AG0	23.0	18.5	30.7
LTE Band 66/4	F	AG1	23.0	20.0	18.0
LTE Band 25/2	A	AG0	23.0	18.0	30.8
LTE Band 25/2	F	AG1	23.0	20.0	18.0
LTE Band 41 PC3	B	AG0	22.0	19.5	34.7
LTE Band 41 PC3	F	AG1	22.0	19.0	14.5
LTE Band 41 PC2	B	AG0	21.5	19.5	34.7
LTE Band 41 PC2	F	AG1	21.5	19.0	14.5
NR Band n5	A	AG0	24.0	23.0	23.0
NR Band n5	E	AG1	24.0	23.0	21.0
NR Band n66	A	AG0	23.5	18.5	23.0
NR Band n66	F	AG1	24.0	20.0	18.0
NR Band n25/n2	A	AG0	23.5	18.0	30.2
NR Band n25/n2	F	AG1	23.0	20.0	18.0
NR Band n41 PC3 (Path 1)	F	AG1	24.0	18.0	17.5
NR Band n41 PC3 (Path 1)	B	AG0	23.0	14.0	13.5
NR Band n41 PC3 (Path 1)	E	AG1	22.5	13.5	13.0
NR Band n41 PC3 (Path 1)	D	AG0	20.0	13.0	12.5
NR Band n41 PC3 (Path 2)	B	AG0	24.0	14.0	13.5
NR Band n41 PC3 (Path 2)	F	AG1	21.0	18.0	17.5
NR Band n41 PC3 (Path 2)	D	AG0	19.0	13.0	12.5
NR Band n41 PC3 (Path 2)	E	AG1	21.0	13.5	13.0
NR Band n77 PC2	F	AG1	25.5	17.0	16.0
NR Band n77 PC2	C	AG0	19.0	12.0	11.0
NR Band n77 PC2	I	AG1	23.5	15.5	14.5
NR Band n77 PC2	D	AG0	18.0	11.5	10.5
2.4 GHz WIFI	H	AG1	19.0	20.1	13.0
2.4 GHz WIFI	J	AG1	19.0	25.1	13.0
2.4 GHz WIFI	MIMO	AG1	19.0	19.6	13.0
5 GHz WIFI	H	AG1	17.0	16.0	13.0
5 GHz WIFI	E	AG1	17.0	16.0	13.0
5 GHz WIFI	MIMO	AG1	17.0	16.0	13.0
6 GHz WIFI	H	AG1	16.0	10.5	9.0
6 GHz WIFI	E	AG1	16.0	10.5	9.0
6 GHz WIFI	MIMO	AG1	16.0	10.5	9.0
2.4 GHz Bluetooth	H	AG1	17.4	20.2	10.9
2.4 GHz Bluetooth	J	AG1	17.4	26.9	10.9
2.4 GHz Bluetooth	MIMO	AG1	10.9	19.3	17.7

4 EQUIPMENT LIST

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	E4404B	Spectrum Analyzer	N/A	N/A	N/A	MY45113242
Agilent	E4438C	ESG Vector Signal Generator	2023-11-14	Annual	2024-11-14	MY45093852
Agilent	E4438C	ESG Vector Signal Generator	2023-11-15	Annual	2024-11-15	MY45092078
Agilent	N5182A	MXG Vector Signal Generator	2024-03-15	Annual	2025-03-15	MY47420651
Agilent	N5182A	MXG Vector Signal Generator	2024-03-07	Annual	2025-03-07	MY47420603
Agilent	8753ES	S-Parameter Vector Network Analyzer	2024-01-10	Annual	2025-01-10	MY40001472
Agilent	8753ES	S-Parameter Vector Network Analyzer	2024-03-06	Annual	2025-03-06	MY40000670
Agilent	E5515C	Wireless Communications Test Set	CBT	N/A	CBT	GB46310798
Agilent	E5515C	Wireless Communications Test Set	CBT	N/A	CBT	US41140256
Agilent	N4010A	Wireless Communications Test Set	2024-07-10	Annual	2025-07-10	GB46170464
Amplifier Research	15S1G6	Amplifier	CBT	N/A	CBT	433973
Amplifier Research	15S1G6	Amplifier	CBT	N/A	CBT	433974
Amplifier Research	15S1G6	Amplifier	2024-07-10	Annual	2025-07-10	390882
Anritsu	MN8110B	I/O Adaptor	CBT	N/A	CBT	6261747881
Anritsu	ML2496A	Power Meter	2024-06-24	Annual	2025-06-24	1840005
Anritsu	ML2495A	Power Meter	2024-07-08	Annual	2025-07-08	1039008
Anritsu	MA2411B	Pulse Power Sensor	2024-07-01	Annual	2025-07-01	1911105
Anritsu	MA2411B	Pulse Power Sensor	2023-11-08	Annual	2024-11-08	1027293
Anritsu	MA24106A	USB Power Sensor	2024-07-09	Annual	2025-07-09	1244512
Anritsu	MA24106A	USB Power Sensor	2024-01-10	Annual	2025-01-10	1344557
Anritsu	MA24408A	Microwace Peak Power Sensor	2024-04-08	Annual	2025-04-08	11679
Anritsu	MT8821C	Radio Communication Analyzer MT8821C	2023-12-15	Annual	2024-12-15	6200901190
Anritsu	MT8821C	Radio Communication Analyzer MT8821C	2024-05-15	Annual	2025-05-15	6262150047
Anritsu	MT8821C	Radio Communication Analyzer MT8821C	2024-05-30	Annual	2025-05-30	6262044715
Anritsu	MT8000A	Radio Communication Test Station	2024-04-10	Annual	2025-04-10	6261987983
Anritsu	MT8000A	Radio Communication Test Station	2024-05-02	Annual	2025-05-02	6272337436
Anritsu	MA24106A	USB Power Sensor	2023-12-04	Annual	2024-12-04	1520501
Anritsu	MA24106A	USB Power Sensor	2024-04-15	Annual	2025-04-15	1827528
Mini-Circuits	PWR-4GHS	USB Power Sensor	2024-06-12	Annual	2025-06-12	12001070013
Control Company	4052	Long Stem Thermometer	2024-02-27	Biennial	2026-02-27	240174346
Control Company	4052	Long Stem Thermometer	2024-02-27	Biennial	2026-02-27	240171096
Control Company	4052	Long Stem Thermometer	2024-02-27	Biennial	2026-02-27	240171059
Control Company	4352	Ultra Long Stem Thermometer	2024-01-15	Annual	2025-01-15	160508097
Control Company	4040	Therm./Clock/Humidity Monitor	2024-04-15	Biennial	2026-04-15	240310280
Control Company	4040	Therm./Clock/Humidity Monitor	2024-04-15	Biennial	2026-04-15	240310282
Control Company	S66279	Therm./Clock/Humidity Monitor	2024-02-16	Biennial	2026-02-16	240140051
Testo	608-H1	ALARM-HYGROMETER	2024-04-11	Annual	2025-04-11	83316971
Testo	608-H1	ALARM-HYGROMETER	2024-04-11	Annual	2025-04-11	83316952
Testo	608-H1	ALARM-HYGROMETER	2024-04-11	Annual	2025-04-11	83316953
Mitutoyo	500-196-30	CD-6"ASX 6Inch Digital Caliper	2022-02-16	Triennial	2025-02-16	A20238413
Keysight Technologies	N9020A	MXA Signal Analyzer	2024-07-08	Annual	2025-07-08	MY48010233
Keysight Technologies	N9020A	MXA Signal Analyzer	2024-04-11	Annual	2025-04-11	MY54500644
Agilent	N9020A	MXA Signal Analyzer	2024-06-14	Annual	2025-06-14	MY56470202
Agilent	N9020A	MXG Vector Signal Generator	2024-07-08	Annual	2025-07-08	MY48010233
MCL	BW-N10W5+	10dB Attenuator	2024-07-09	Annual	2025-07-09	1507
MCL	BW-N6W5+	6dB Attenuator	CBT	N/A	CBT	1139
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	CBT	N/A	CBT	31634
Mini-Circuits	BW-N20W5+	DC to 18 GHz Precision Fixed 20 dB Attenuator	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	2024-07-10	Annual	2025-07-10	31634
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	2024-07-10	Annual	2025-07-10	UU13301538
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	2024-07-10	Annual	2025-07-10	UU19201507
Mini-Circuits	BW-N20W5	Power Attenuator	CBT	N/A	CBT	1226
Mini-Circuits	ZUDC10-83-S+	Directional Coupler	2024-07-09	Annual	2025-07-09	2111
Mini-Circuits	ZUDC10-83-S+	Directional Coupler	CBT	N/A	CBT	2050
Narda	4772-3	Attenuator (3dB)	CBT	N/A	CBT	9406
Narda	BW-S3W2	Attenuator (3dB)	CBT	N/A	CBT	120
MCL	BW-N3W5+	3dB Attenuator	2024-07-09	Annual	2025-07-09	1608
Seekonk	TSF-100	Torque Wrench	2024-10-16	Annual	2025-10-16	47639-29
Seekonk	NC-100	Torque Wrench	2024-04-02	Biennial	2026-04-02	1262
Agilent	E5515C	Wireless Communications Test Set	2024-01-10	Annual	2025-01-10	MY50262130
Rohde & Schwarz	CMW500	Wideban Radio Communication Tester	2024-01-11	Annual	2025-01-11	150117
Rohde & Schwarz	CMW500	Wideban Radio Communication Tester	2024-01-10	Annual	2025-01-10	131454
Rohde & Schwarz	CMW500	Wideban Radio Communication Tester	2024-04-24	Annual	2025-04-24	167284
Rohde & Schwarz	CMW500	Wideban Radio Communication Tester	2024-07-08	Annual	2025-07-08	166818
Rohde & Schwarz	CMW500	Wideban Radio Communication Tester	2024-01-10	Annual	2025-01-10	150117
Rohde & Schwarz	CMW500	Wideban Radio Communication Tester	2024-01-11	Annual	2025-01-11	171075

SPEAG	DAK-3.5	Dielectric Assessment Kit	2023-11-13	Annual	2024-11-13	1277
SPEAG	DAK-3.5	Dielectric Assessment Kit	2023-10-25	Annual	2024-10-25	1091
SPEAG	DAKS-3.5	Portable Dielectric Assessment Kit	2024-07-08	Annual	2025-07-08	1039
SPEAG	MAIA	MAIA Modulation and Audio Interference	N/A	N/A	N/A	1237
SPEAG	MAIA	MAIA Modulation and Audio Interference	N/A	N/A	N/A	1331
SPEAG	MAIA	MAIA Modulation and Audio Interference	N/A	N/A	N/A	1390
SPEAG	DAK-12	Dielectric Assessment Kit (4MHz - 3GHz)	2024-03-11	Annual	2025-03-11	1102
SPEAG	CLA-13	Confined Loop Antenna	2023-11-09	Annual	2024-11-09	1004
SPEAG	D750V3	750 MHz SAR Dipole	2023-09-13	Biennial	2025-09-13	1097
SPEAG	D835V2	835 MHz SAR Dipole	2024-01-18	Annual	2025-01-18	4d132
SPEAG	D835V2	835 MHz SAR Dipole	2022-11-18	Biennial	2024-11-18	4d108
SPEAG	D835V2	835 MHz SAR Dipole	2024-04-08	Annual	2025-04-08	4d119
SPEAG	D1750V2	1750 MHz SAR Dipole	2022-01-18	Triennial	2025-01-18	1148
SPEAG	D1750V2	1750 MHz SAR Dipole	2021-10-20	Triennial	2024-10-20	1150
SPEAG	D1750V2	1750 MHz SAR Dipole	2024-04-15	Annual	2025-04-15	1051
SPEAG	D1900V2	1900 MHz SAR Dipole	2022-08-08	Triennial	2025-08-08	5d080
SPEAG	D1900V2	1900 MHz SAR Dipole	2022-02-21	Triennial	2025-02-21	5d148
SPEAG	D1900V2	1900 MHz SAR Dipole	2024-07-10	Annual	2025-07-10	5d149
SPEAG	D1900V2	1900 MHz SAR Dipole	2024-04-12	Annual	2025-04-12	5d141
SPEAG	D2450V2	2450 MHz SAR Dipole	2024-02-08	Annual	2025-02-08	882
SPEAG	D2450V2	2450 MHz SAR Dipole	2024-05-10	Annual	2025-05-10	945
SPEAG	D2600V2	2600 MHz SAR Dipole	2024-06-14	Annual	2025-06-14	1009
SPEAG	D2600V2	3500 MHz SAR Dipole	2023-12-13	Annual	2023-12-13	1068
SPEAG	D3500V2	3500 MHz SAR Dipole	2024-06-10	Annual	2025-06-10	1127
SPEAG	D3700V2	3700 MHz SAR Dipole	2023-12-13	Annual	2024-12-13	1029
SPEAG	D3700V2	3700 MHz SAR Dipole	2024-06-10	Annual	2025-06-10	1096
SPEAG	D3900V2	3900 MHz SAR Dipole	2024-06-10	Annual	2025-06-10	1074
SPEAG	D5GHzV2	5 GHz SAR Dipole	2024-04-09	Annual	2025-04-09	1237
SPEAG	D6.5GHzV2	6.5 GHz SAR Dipole	2024-01-10	Annual	2025-01-10	1018
SPEAG	D6.5GHzV2	6.5 GHz SAR Dipole	2024-02-22	Annual	2025-02-22	1111
SPEAG	5G Verification Source 10GHz	10GHz System Verification Antenna	2024-10-08	Annual	2025-10-08	1006
SPEAG	5G Verification Source 10GHz	10GHz System Verification Antenna	2024-03-05	Annual	2025-03-05	1002
SPEAG	EX3DV4	SAR Probe	2024-09-11	Annual	2025-09-11	7558
SPEAG	EX3DV4	SAR Probe	2024-01-16	Annual	2025-01-16	7565
SPEAG	EX3DV4	SAR Probe	2024-09-02	Annual	2025-09-02	7491
SPEAG	EX3DV4	SAR Probe	2024-04-16	Annual	2025-04-16	7357
SPEAG	EX3DV4	SAR Probe	2024-02-09	Annual	2025-02-09	7427
SPEAG	EX3DV4	SAR Probe	2024-06-17	Annual	2025-06-17	7409
SPEAG	EX3DV4	SAR Probe	2024-02-09	Annual	2025-02-09	7640
SPEAG	EX3DV4	SAR Probe	2024-07-18	Annual	2025-07-18	7406
SPEAG	EX3DV4	SAR Probe	2024-06-28	Annual	2025-06-28	7803
SPEAG	EX3DV4	SAR Probe	2024-05-10	Annual	2025-05-10	3914
SPEAG	EX3DV4	SAR Probe	2024-04-17	Annual	2025-04-17	7718
SPEAG	EX3DV4	SAR Probe	2024-04-17	Annual	2025-04-17	7637
SPEAG	EX3DV5	SAR Probe	2024-05-10	Annual	2025-05-10	7402
SPEAG	EX3DV6	SAR Probe	2024-03-11	Annual	2025-03-11	7421
SPEAG	EX3DV4	SAR Probe	2024-03-08	Annual	2025-03-08	7527
SPEAG	EX3DV4	SAR Probe	2024-02-09	Annual	2025-02-09	7308
SPEAG	EUmmWV4	EUmmWV4 Probe	2024-02-02	Annual	2025-02-02	9622
SPEAG	EUmmWV4	EUmmWV4 Probe	2024-01-09	Annual	2025-01-09	9523
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-09-10	Annual	2025-09-10	1364
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-01-16	Annual	2025-01-16	1466
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-08-08	Annual	2025-08-08	1532
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-04-09	Annual	2025-04-09	1582
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-02-09	Annual	2025-02-09	467
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-06-11	Annual	2025-06-11	1334
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-02-09	Annual	2025-02-09	1645
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-07-08	Annual	2025-07-08	1677
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-07-08	Annual	2025-07-08	1583
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-05-08	Annual	2025-05-08	728
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-03-01	Annual	2025-03-01	665
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-04-09	Annual	2025-04-09	1652
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-05-08	Annual	2025-05-08	1502
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-03-06	Annual	2025-03-06	604
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-03-12	Annual	2025-03-12	1272
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-03-06	Annual	2025-03-06	534
SPEAG	DAE4	Dasy Data Acquisition Electronics	2024-09-10	Annual	2025-09-10	1449
SPEAG	DAE4	Dasy Data Acquisition Electronics	2023-12-07	Annual	2024-12-07	1644

Note: CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, amplifier, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.
Note: All equipment was used solely within its respective calibration period.

5 MEASUREMENT UNCERTAINTIES

Applicable for SAR measurements < 6GHz:

a	b	c	d	e= f(d,k)	f	g	h = c x f/e	i = c x g/e	k
Uncertainty Component	IEEE 1528 Sec.	Tol. (± %)	Prob. Dist.	Div.	c_i 1gm	c_i 10 gms	1gm u_i (± %)	10gms u_i (± %)	v_i
Measurement System									
Probe Calibration	E.2.1	7	N	1	1	1	7.0	7.0	∞
Axial Isotropy	E.2.2	0.25	N	1	0.7	0.7	0.2	0.2	∞
Hemishperical Isotropy	E.2.2	1.3	N	1	0.7	0.7	0.9	0.9	∞
Boundary Effect	E.2.3	2	R	1.73	1	1	1.2	1.2	∞
Linearity	E.2.4	0.3	N	1	1	1	0.3	0.3	∞
System Detection Limits	E.2.4	0.25	R	1.73	1	1	0.1	0.1	∞
Modulation Response	E.2.5	4.8	R	1.73	1	1	2.8	2.8	∞
Readout Electronics	E.2.6	0.3	N	1	1	1	0.3	0.3	∞
Response Time	E.2.7	0.8	R	1.73	1	1	0.5	0.5	∞
Integration Time	E.2.8	2.6	R	1.73	1	1	1.5	1.5	∞
RF Ambient Conditions - Noise	E.6.1	3	R	1.73	1	1	1.7	1.7	∞
RF Ambient Conditions - Reflections	E.6.1	3	R	1.73	1	1	1.7	1.7	∞
Probe Positioner Mechanical Tolerance	E.6.2	0.8	R	1.73	1	1	0.5	0.5	∞
Probe Positioning w/ respect to Phantom	E.6.3	6.7	R	1.73	1	1	3.9	3.9	∞
Extrapolation, Interpolation & Integration algorithms for Max. SAR Evaluation	E.5	4	R	1.73	1	1	2.3	2.3	∞
Test Sample Related									
Test Sample Positioning	E.4.2	3.12	N	1	1	1	3.1	3.1	35
Device Holder Uncertainty	E.4.1	1.67	N	1	1	1	1.7	1.7	5
Output Power Variation - SAR drift measurement	E.2.9	5	R	1.73	1	1	2.9	2.9	∞
SAR Scaling	E.6.5	0	R	1.73	1	1	0.0	0.0	∞
Phantom & Tissue Parameters									
Phantom Uncertainty (Shape & Thickness tolerances)	E.3.1	7.6	R	1.73	1.0	1.0	4.4	4.4	∞
Liquid Conductivity - measurement uncertainty	E.3.3	4.3	N	1	0.78	0.71	3.3	3.0	76
Liquid Permittivity - measurement uncertainty	E.3.3	4.2	N	1	0.23	0.26	1.0	1.1	75
Liquid Conductivity - Temperature Uncertainty	E.3.4	3.4	R	1.73	0.78	0.71	1.5	1.4	∞
Liquid Permittivity - Temperature Unceritainty	E.3.4	0.6	R	1.73	0.23	0.26	0.1	0.1	∞
Liquid Conductivity - deviation from target values	E.3.2	5.0	R	1.73	0.64	0.43	1.8	1.2	∞
Liquid Permittivity - deviation from target values	E.3.2	5.0	R	1.73	0.60	0.49	1.7	1.4	∞
Combined Standard Uncertainty (k=1)			RSS				12.2	12.0	191
Expanded Uncertainty (95% CONFIDENCE LEVEL)			k=2				24.4	24.0	

The above measurement uncertainties are according to IEEE Std. 1528-2013

Applicable for SAR measurements > 6GHz:

a	b	c	d	e= f(d,k)	f	g	h = c x f/e	i = c x g/e	k
Uncertainty Component	IEEE 1528 Sec.	Tol. (± %)	Prob. Dist.	Div.	c_i 1gm	c_i 10 gms	1gm u_i (± %)	10gms u_i (± %)	v_i
Measurement System									
Probe Calibration	E.2.1	9.3	N	1	1	1	9.3	9.3	∞
Axial Isotropy	E.2.2	0.25	N	1	0.7	0.7	0.2	0.2	∞
Hemishperical Isotropy	E.2.2	1.3	N	1	0.7	0.7	0.9	0.9	∞
Boundary Effect	E.2.3	2	R	1.73	1	1	1.2	1.2	∞
Linearity	E.2.4	0.3	N	1	1	1	0.3	0.3	∞
System Detection Limits	E.2.4	0.25	R	1.73	1	1	0.1	0.1	∞
Modulation Response	E.2.5	4.8	R	1.73	1	1	2.8	2.8	∞
Readout Electronics	E.2.6	0.3	N	1	1	1	0.3	0.3	∞
Response Time	E.2.7	0.8	R	1.73	1	1	0.5	0.5	∞
Integration Time	E.2.8	2.6	R	1.73	1	1	1.5	1.5	∞
RF Ambient Conditions - Noise	E.6.1	3	R	1.73	1	1	1.7	1.7	∞
RF Ambient Conditions - Reflections	E.6.1	3	R	1.73	1	1	1.7	1.7	∞
Probe Positioner Mechanical Tolerance	E.6.2	0.8	R	1.73	1	1	0.5	0.5	∞
Probe Positioning w/ respect to Phantom	E.6.3	6.7	R	1.73	1	1	3.9	3.9	∞
Extrapolation, Interpolation & Integration algorithms for Max. SAR Evaluation	E.5	4	R	1.73	1	1	2.3	2.3	∞
Test Sample Related									
Test Sample Positioning	E.4.2	3.12	N	1	1	1	3.1	3.1	35
Device Holder Uncertainty	E.4.1	1.67	N	1	1	1	1.7	1.7	5
Output Power Variation - SAR drift measurement	E.2.9	5	R	1.73	1	1	2.9	2.9	∞
SAR Scaling	E.6.5	0	R	1.73	1	1	0.0	0.0	∞
Phantom & Tissue Parameters									
Phantom Uncertainty (Shape & Thickness tolerances)	E.3.1	7.6	R	1.73	1.0	1.0	4.4	4.4	∞
Liquid Conductivity - measurement uncertainty	E.3.3	4.3	N	1	0.78	0.71	3.3	3.0	76
Liquid Permittivity - measurement uncertainty	E.3.3	4.2	N	1	0.23	0.26	1.0	1.1	75
Liquid Conductivity - Temperature Uncertainty	E.3.4	3.4	R	1.73	0.78	0.71	1.5	1.4	∞
Liquid Permittivity - Temperature Unceritainty	E.3.4	0.6	R	1.73	0.23	0.26	0.1	0.1	∞
Liquid Conductivity - deviation from target values	E.3.2	5.0	R	1.73	0.64	0.43	1.8	1.2	∞
Liquid Permittivity - deviation from target values	E.3.2	5.0	R	1.73	0.60	0.49	1.7	1.4	∞
Combined Standard Uncertainty (k=1)			RSS				13.8	13.6	191
Expanded Uncertainty (95% CONFIDENCE LEVEL)			k=2				27.6	27.1	

The above measurement uncertainties are according to IEEE Std. 1528-2013

Applicable for Power Density Measurements:

a	b	c	d	e	f = c x f/e	g
Uncertainty Component	Unc. (± dB)	Prob. Dist.	Div.	c_i	u_i (± dB)	v_i
Measurement System						
Calibration	0.49	N	1	1	0.49	∞
Probe Correction	0.00	R	1.73	1	0.00	∞
Frequency Response	0.20	R	1.73	1	0.12	∞
Sensor Cross Coupling	0.00	R	1.73	1	0.00	∞
Isotropy	0.50	R	1.73	1	0.29	∞
Linearity	0.20	R	1.73	1	0.12	∞
Probe Scattering	0.00	R	1.73	1	0.00	∞
Probe Positioning offset	0.30	R	1.73	1	0.17	∞
Probe Positioning Repeatability	0.04	R	1.73	1	0.02	∞
Sensor MechanicalOffset	0.00	R	1.73	1	0.00	∞
Probe Spatial Resolution	0.00	R	1.73	1	0.00	∞
Field Impedence Dependance	0.00	R	1.73	1	0.00	∞
Amplitude and Phase Drift	0.00	R	1.73	1	0.00	∞
Amplitude and Phase Noise	0.04	R	1.73	1	0.02	∞
Measurement Area Truncation	0.00	R	1.73	1	0.00	∞
Data Acquisition	0.03	N	1	1	0.03	∞
Sampling	0.00	R	1.73	1	0.00	∞
Field Reconstruction	2.00	R	1.73	1	1.15	∞
Forward Transformation	0.00	R	1.73	1	0.00	∞
Power Density Scaling	0.00	R	1.73	1	0.00	∞
Spatial Averaging	0.10	R	1.73	1	0.06	∞
System Detection Limit	0.04	R	1.73	1	0.02	∞
Test Sample Related						
Probe Coupling with DUT	0.00	R	1.73	1	0.00	∞
Modulation Response	0.40	R	1.73	1	0.23	∞
Integration Time	0.00	R	1.73	1	0.00	∞
Response Time	0.00	R	1.73	1	0.00	∞
Device Holder Influence	0.10	R	1.73	1	0.06	∞
DUT alignment	0.00	R	1.73	1	0.00	∞
RF Ambient Conditions	0.04	R	1.73	1	0.02	∞
Ambient Reflections	0.04	R	1.73	1	0.02	∞
Immunity/Secondary Reception	0.00	R	1.73	1	0.00	∞
Drift of DUT	0.21	R	1.73	1	0.12	∞
Combined Standard Uncertainty (k=1)		RSS			1.34	∞
Expanded Uncertainty (95% CONFIDENCE LEVEL)		k=2			2.68	